


<b>Search Notes</b>  	<b>Application/Control No.</b>  10721225	<b>Applicant(s)/Patent Under Reexamination</b>  LUETZEN ET AL.
	<b>Examiner</b>  Binh X Tran	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
438	700, 719, 733, 734, 753	7/24/2009	BT
438	700, 719, 733, 734, 753	12/30/2009	BT

SEARCH NOTES		
Search Notes	Date	Examiner
Update search using databases in EAST	7/24/2009	BT
Update inventor's name search	12/30/2009	BT
Update keywords using databases in EAST	12/30/2009	BT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
438	700, 719, 733, 734, 753	12/30/2009	BT

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